

NTE2592 Silicon NPN Transistor Horizontal Output for HDTV

Features:

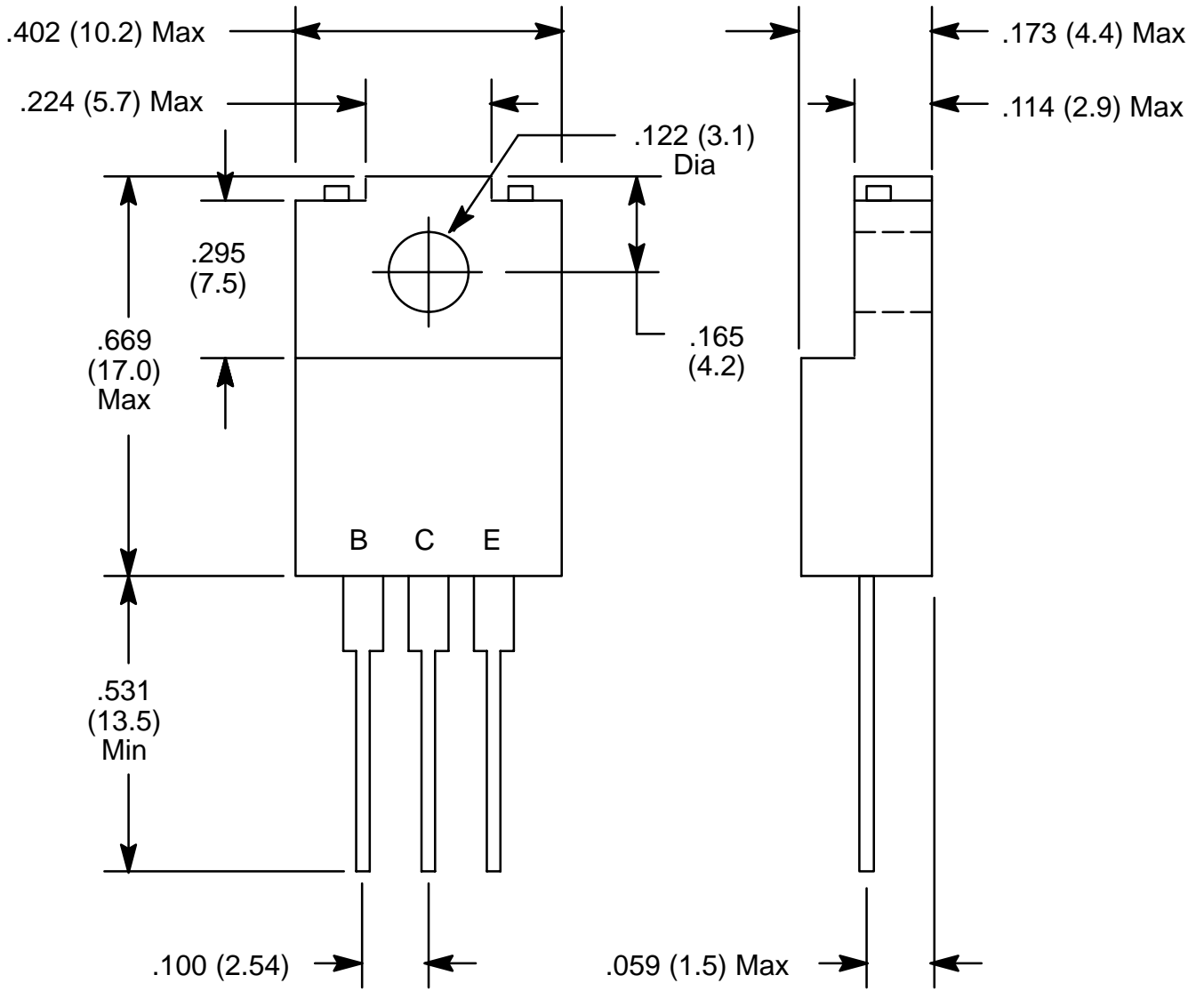
- High Breakdown Voltage: $V_{(BR)CBO} = 2000V$ Min
- Isolated TO220 Type Package

Absolute Maximum Ratings: ($T_C = +25^\circ C$ unless otherwise specified)

Collector–Base Voltage, V_{CBO}	2000V
Collector–Emitter Voltage, V_{CEO}	1800V
Emitter–Base Voltage, V_{EBO}	5V
Collector Current, I_C	
Continuous	15mA
Peak	50mA
Collector Power Dissipation, P_C	2W
Junction Temperature Range, T_J	+150°C
Storage Temperature Range, T_{stg}	–55° to +150°C
Maximum Thermal Resistance, Junction–to–Case, R_{thJC}	8.3°C/W

Electrical Characteristics: ($T_C = +25^\circ C$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 1800V, I_E = 0$	–	–	1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 4V, I_C = 0$	–		1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 300\mu A$	10	–	60	
Gain Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 300\mu A$	–	6	–	MHz
Collector–Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 600\mu A, I_B = 120\mu A$	–	–	5	V
Base–Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 600\mu A, I_B = 120\mu A$	–	–	2	V
Collector–Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = 100\mu A, I_E = 0$	2000	–	–	V
Collector–Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = 100\mu A, R_{BE} = \infty$	1800	–	–	V
Emitter–Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E = 10\mu A, I_C = 0$	5	–	–	V
Output Capacitance	C_{ob}	$V_{CB} = 100V, f = 1MHz$	–	1.8	–	pF



NOTE: Tab is isolated